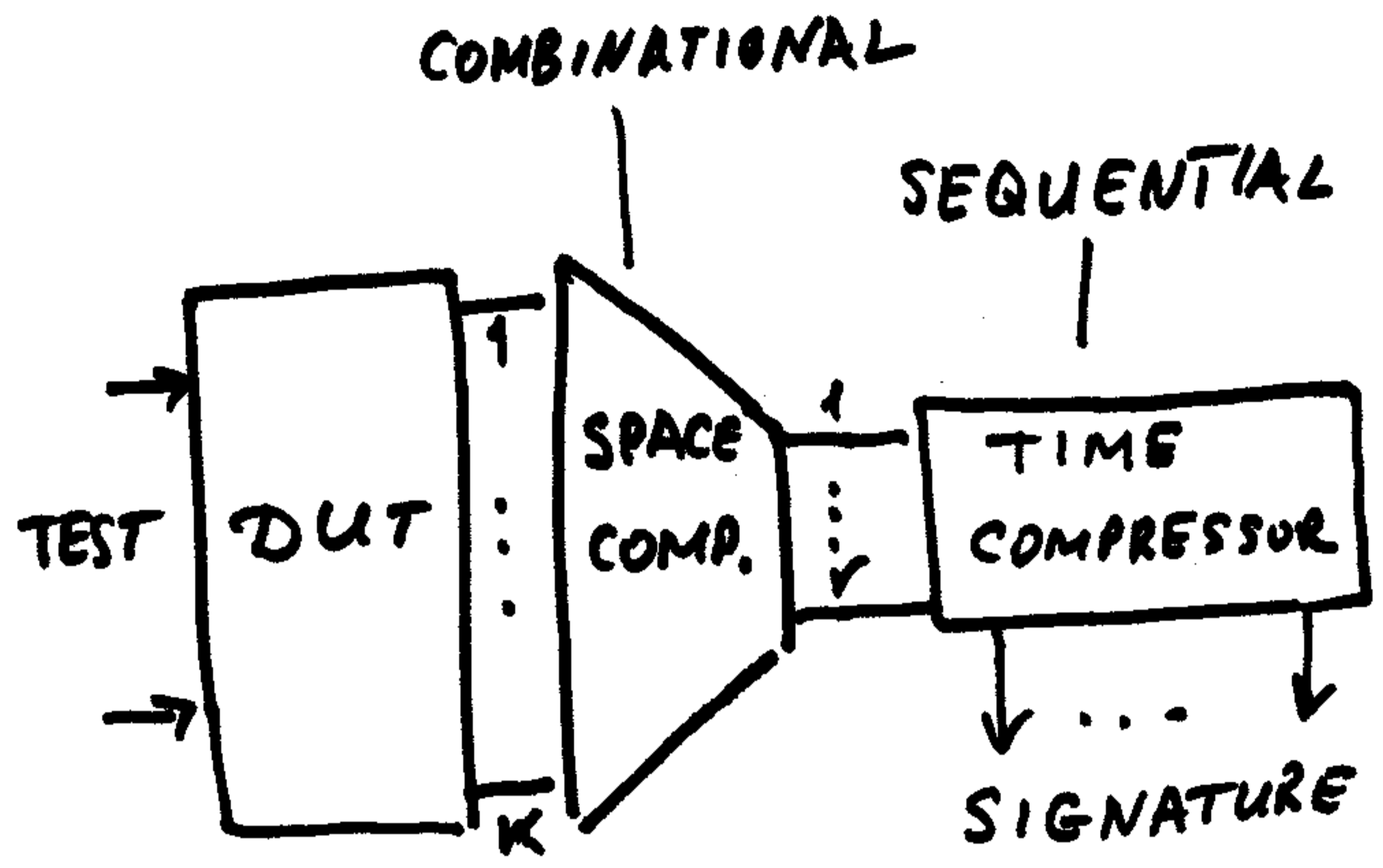


SPACE-TIME COMPRESSION

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TIME COMPRESSORS ARE LFSR,
TRANSITION COUNT, ADDER/
ACCUMULATOR.

PROBLEMS:

1. $\min r(K, e)$
2. CONSTRUCT SC.
3. OVERHEAD
4. PROBABILITY OF MASKING

LINEAR COMPRESSORS \Rightarrow

XOR gates only \Leftrightarrow

DECODERS OF LINEAR

ERROR-DETECTING CODES

Problems: 1) Estimate $\min r$ for a
given K and L (multiplicity
of errors at the output of DUT)

$$r(K, L) = ?$$

2) Design optimal SC with
 $r = r(K, L)$

Solutions in:

K. K. Saluja, M. G. Karpovsky, "Testing
Computer Hardware through Data

Compression in Space and Time"

Proc. Int. Test Conf. 1983

S. R. Reddy, K. K. Saluja, M. G. Karpovsky

"A Data Compression Technique for
Built-in Self Test", Proc. 1985 Fault

Tolerant Computing Symposium, 1985.

Estimations on a minimal number of observation points

Lower bound

$$r(k, l) \geq \lceil \log_2 \left(\sum_{i=0}^{\lfloor l/2 \rfloor} \binom{k}{i} + \epsilon \right) \rceil$$

$$\epsilon = \begin{cases} 0, & l \text{ - even} \\ \binom{k-1}{\lfloor l/2 \rfloor}, & l \text{ odd} \end{cases}$$

Example 2 $k=6, l=3 \Rightarrow \lfloor l/2 \rfloor = 2,$

$$\epsilon = \binom{5}{2} = 10$$

$$r(6, 3) \geq \lceil \log_2 (1 + 6 + 10) \rceil = 5$$

$$k=32, l=3$$

$$r(32, 3) \geq \lceil \log_2 (1 + 32 + \binom{31}{2}) \rceil = 9$$

Upper bound

$$r(\kappa, \ell) \leq \lceil \log_2 \sum_{i=0}^{\ell} \binom{\kappa-1}{i} \rceil$$

$$\ell \geq 2$$

$$r(\kappa, 1) = 1$$

$$r(\kappa, 2) = \lceil \log_2 (\kappa + 1) \rceil$$

Example 3 $\kappa = 9, \ell = 3$

$$r(9, 3) \leq 7$$

$$\kappa = 32, \ell = 3$$

$$9 \leq r(32, 3) \leq \lceil \log_2 (1 + 31 + \binom{31}{2} + \binom{31}{3}) \rceil = 13$$

Design of Space Compressors by Linear Error Correcting Codes

Let H be a check matrix of a code $V = (k, k-r)$ with distance

≥ 2 . (For any $v \in V$ $Hv = 0$)

Let $Re(H)$ be a network computing syndrome for this code

$Re(H)$ has k inputs and r outputs
uses XOR gates only

Then $SC = Re(H)$

Output of a space compressor may be applied to the input of a time compressor (ex. LFSF with parallel load)

Error: $v \mapsto v^*$ $e = v \oplus v^*$ $l = \|e\|$ - multiplicity of error
 $S = Hv^* = H(v \oplus e) = Hv \oplus He$ - error detected iff $He \neq 0 \Rightarrow$
 $\Rightarrow H$ is a check matrix of a code
- details - l - errors

If there exists $(n, n-r)$ perfect code with distance $e+1$, then

$$r(n, e) = \log_2 \sum_{i=0}^{\lfloor e/2 \rfloor} \binom{n}{i}$$

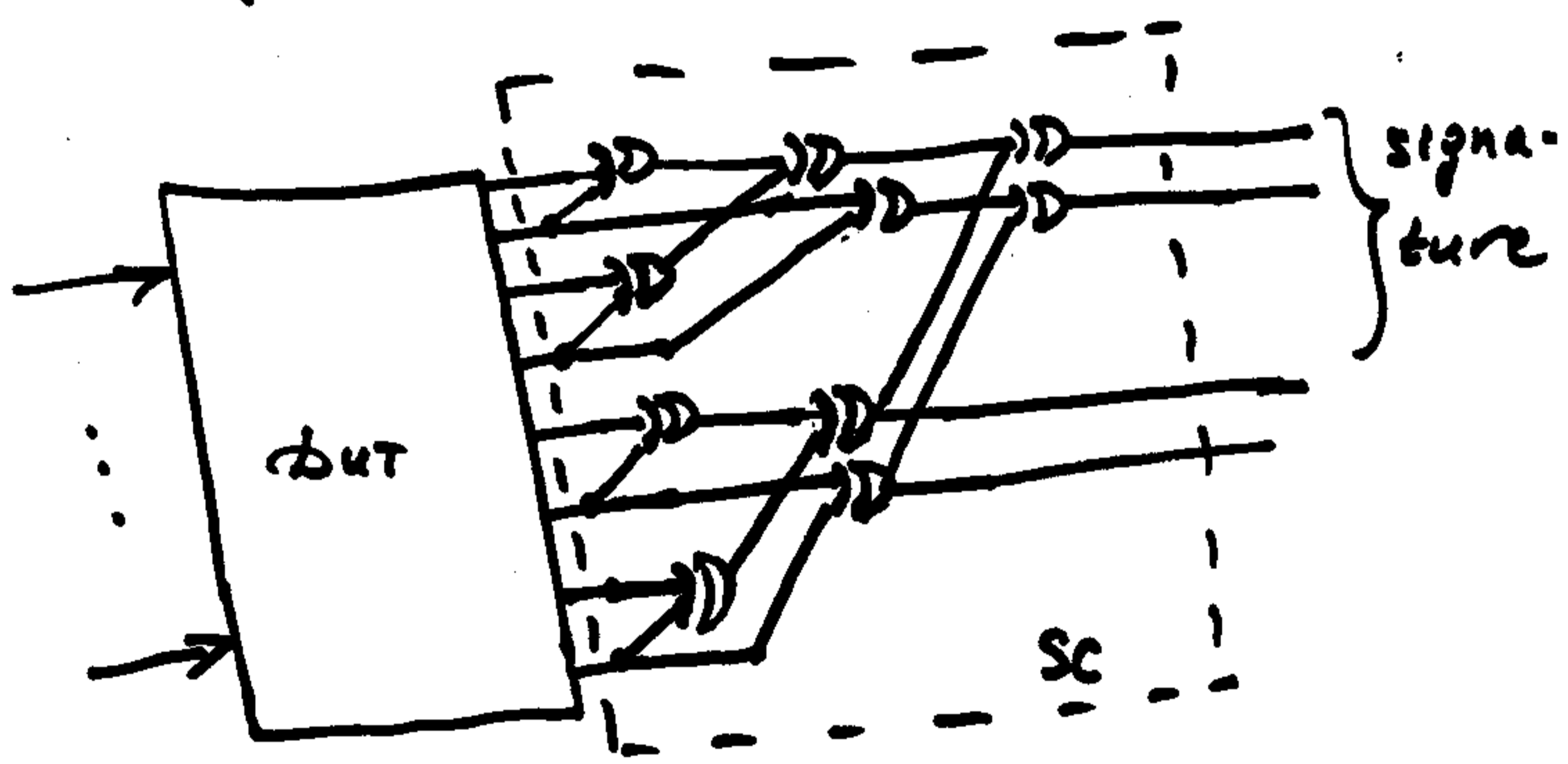
Ex 4.
Since there exists $(23, 12)$ Golay code which is perfect with distance 7 we have

$$r(23, 6) = 11 - \text{number of check bits in the code.}$$

Example 5 $k=8, l=3$

Let us use $(8,4)$ extended Hamming code with $dist = l+1 = 4$

$$H = \begin{pmatrix} 1111 & 1111 \\ 0101 & 0101 \\ 0011 & 0011 \\ 0000 & 1111 \end{pmatrix} \quad \text{then}$$



the SC based on $(8,4)$ extended Hamming Code

joint minimization of functions computing signature. Faults in SC are detected

Bounds on minimal numbers of
Observation Points $r(k, e)$ and the
Corresponding codes

| e | k | $r(k, e)$ | | Code |
|-----|-----------|------------------------------|----------------------------------|-----------------------|
| | | Lower Bound | Upper Bound | |
| 1 | k | 1 | 1 | Parity checking |
| 2 | $2^i - 1$ | i | i | Hamming code |
| 3 | k | $1 + \lceil \log_2 k \rceil$ | $1 + \lceil \log_2 (k+1) \rceil$ | Extended Hamming code |
| 4 | $2^i - 1$ | $2i - 1$ | $2i$ | BCH code |
| 6 | 23 | 11 | 11 | Golay code |

For errors with multiplicity $> l$
the probability of masking an error
in SC is

Errors
uniformly
distributed

$$P = \frac{2^{k-r} - 1}{2^k - 1} \approx 2^{-r}$$

Example 6

MC68020

$k=116$ control outputs for

ROM

take $l=10$ and $(116, 84)$ code

with dist $d=1$

then we have 32-bit signature $r=32$

All errors with multiplicity ≤ 10
detected; for errors with multiplicity
 ≥ 11 probability of masking $\approx 2^{-32}$

- SC maybe:
- 1) part of a tester
 - 2) SC on a chip.

26.12
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Gate counts for sparse compressors

$L(k, l)$ - number of 2-input XOR gates

Ex. $L(k, 1) = k - 1$

$$L(k, l) \leq \lceil \frac{1}{2} (k - r)r + k - 1 \rceil$$

$$r = \lceil \log_2 \sum_{i=0}^l \binom{k-1}{i} \rceil$$

For large k

$$L(k, l) \approx \frac{kr}{\log_2 k}$$

Space Compressors Detecting

(Propagating) a Given Set of Errors

Let C is a code of length $n = k + r$
detecting set E of errors and H
is a check matrix for C

Then $Re(H) = SC$

and $SC(z \oplus e) \neq SC(z)$

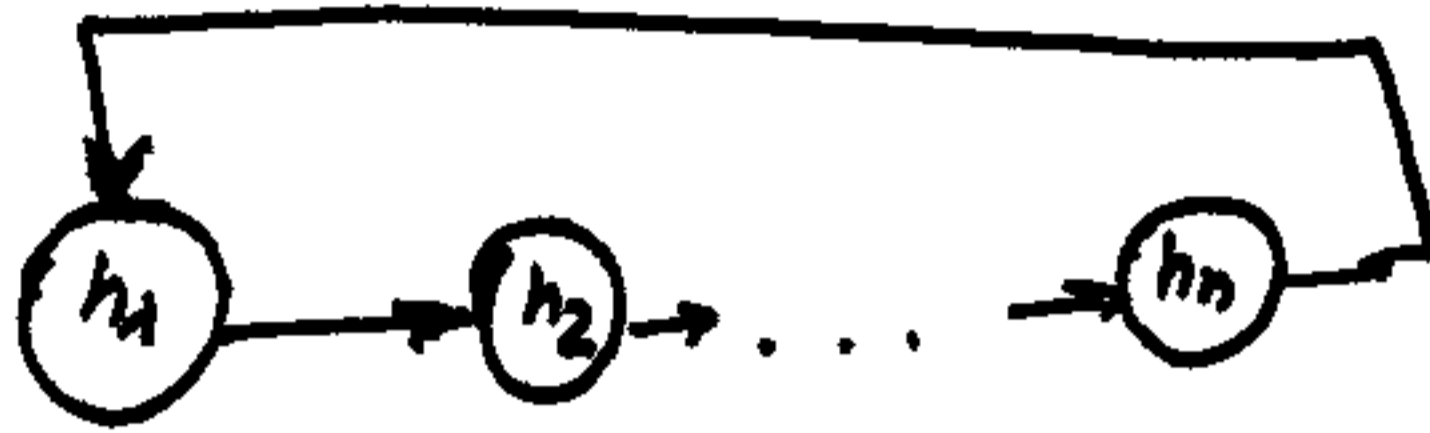
for any $e \in E$.

Time Compressors

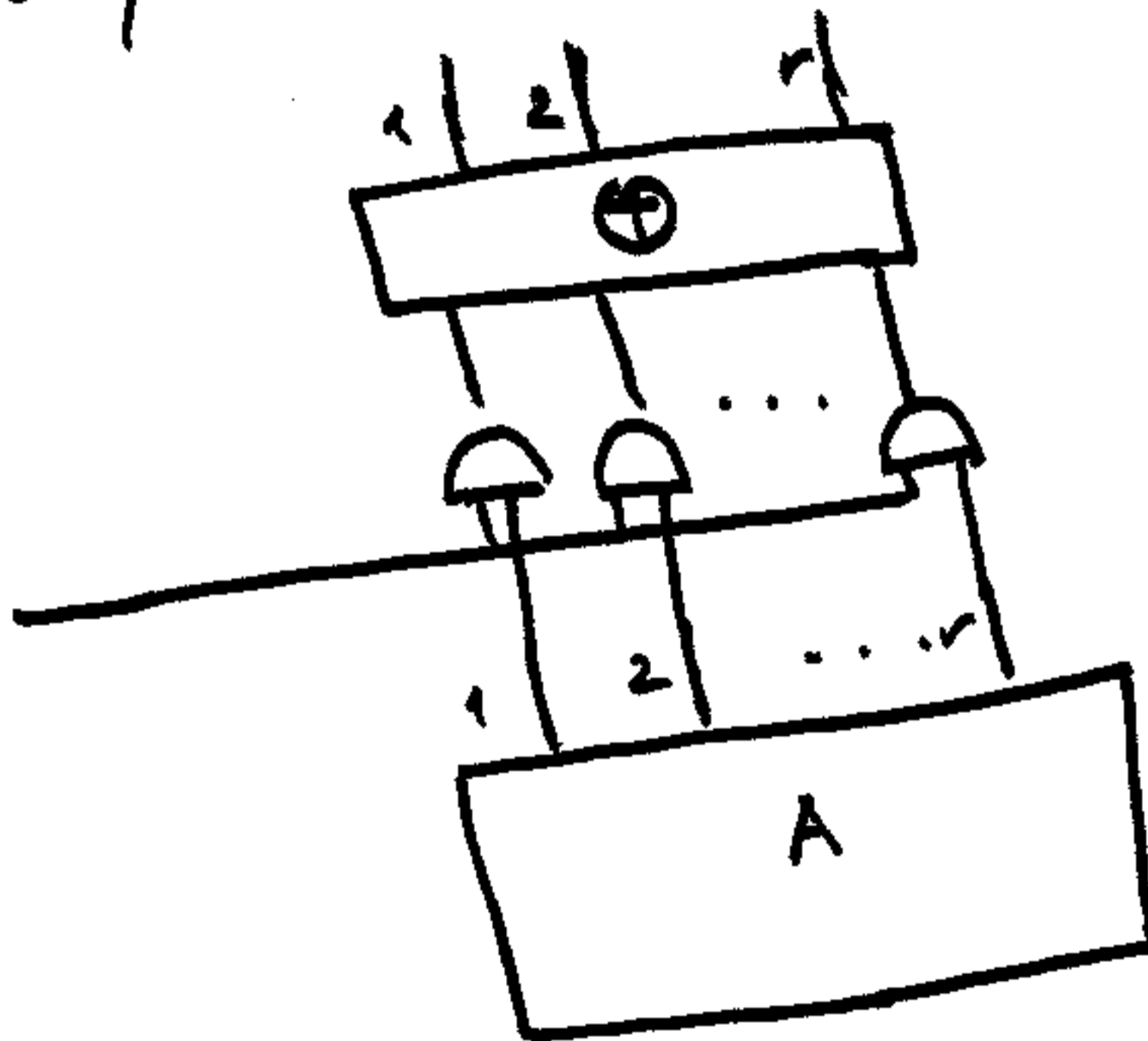
Let $H = [h_1 \ h_2 \ \dots \ h_n]$ $h_i \in \{0, 1\}^r$

then $S = Hz = h_1 z_1 \oplus h_2 z_2 \oplus \dots \oplus h_n z_n$
 $= \bigoplus_i h_i z_i$ $z_i \in \{0, 1\}^k$

Let A is a autonomous sequential^{13/6}
Network with r FFS with transition
diagram



Then for have for the time
compressor



Space Compressors for Specific Classes of Faults

Errors in instruction decoding:

'no decoding' or 'multiple decoding' $\Rightarrow l=1$
'wrong decoding' $\Rightarrow l=2$

SC is a syndrome calculator for
the Hamming code with $dist=3$

If $n=2^m$ then $r=m+1$

only $m+1$ observation points

Errors in ALU

Let single arithmetical errors

SC is a decoder of the $3N$ arithmetical code computing a residue mod 3. for an output of ALU

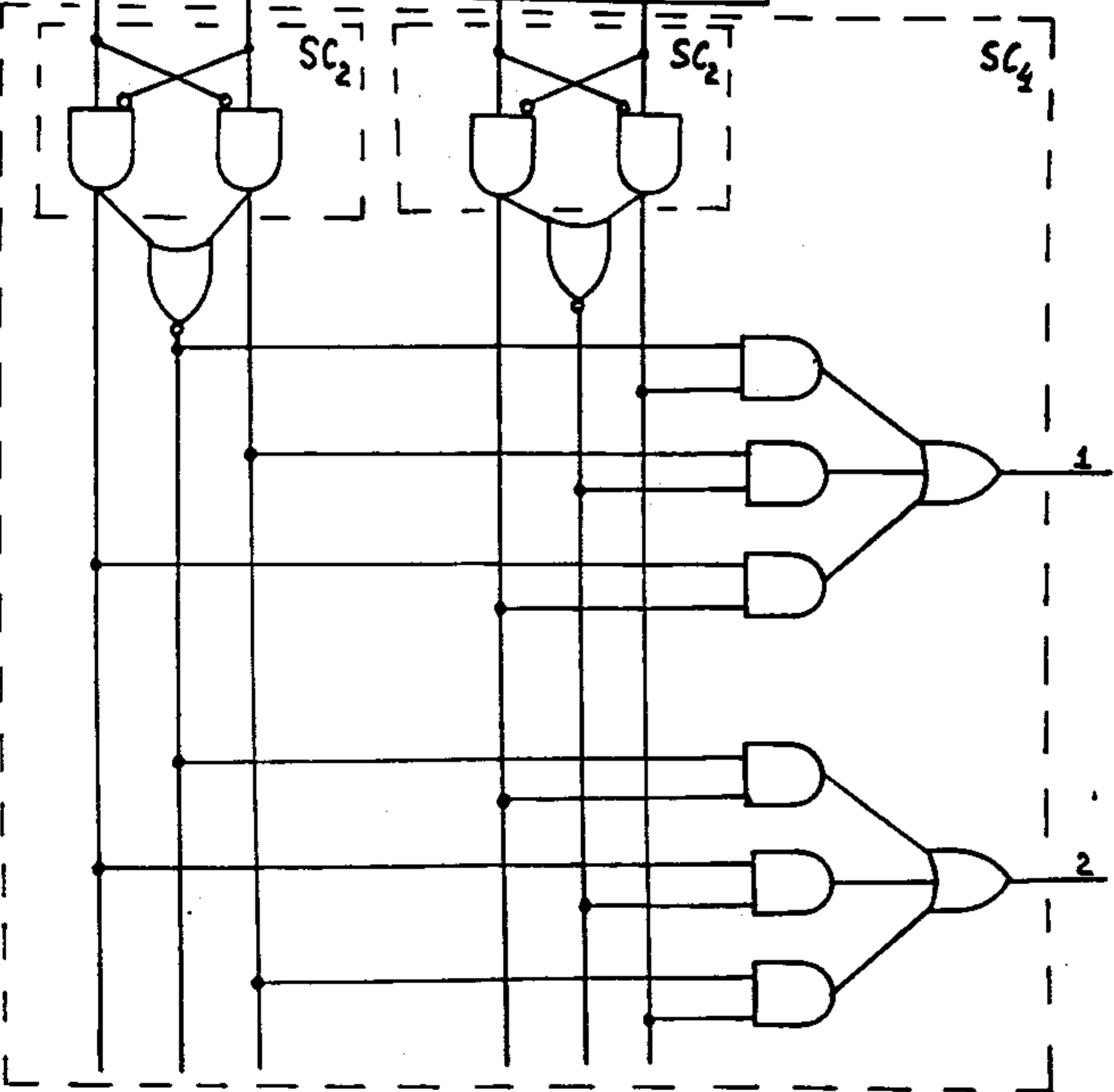
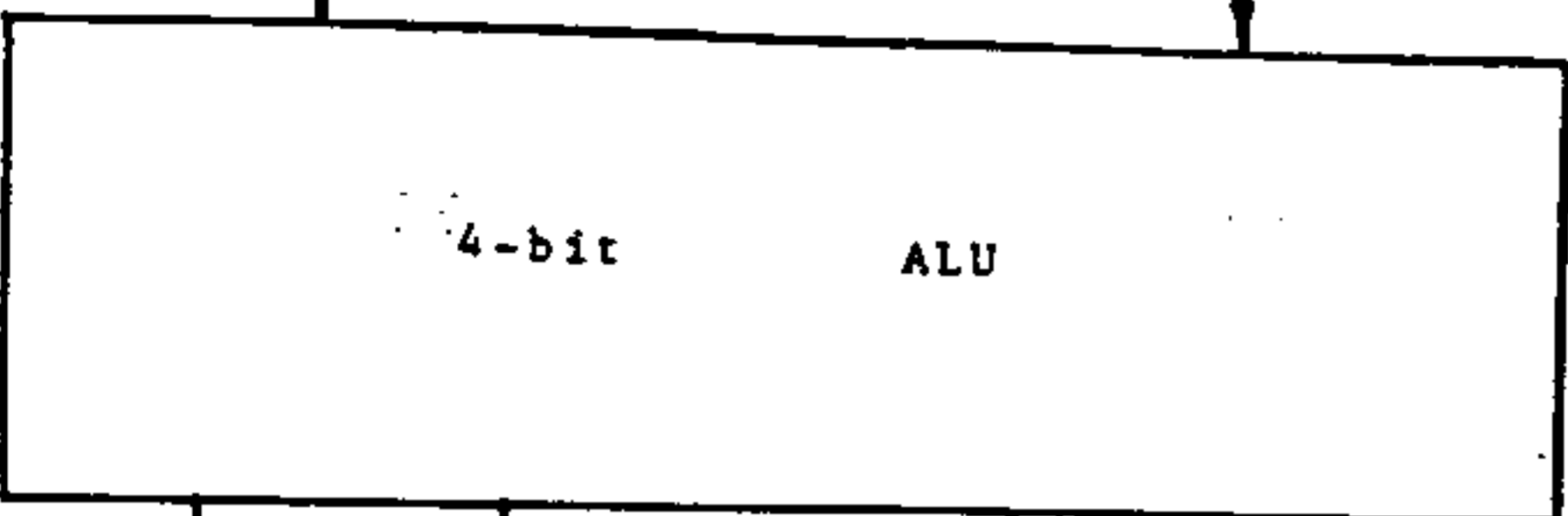
$r=2$

Gate counts (equivalent 2-input gates)
 $L(n)$ for detection of single errors in n -bit ALU

| | | | | | |
|--------|----|----|-----|-----|-----|
| n | 4 | 8 | 16 | 32 | 64 |
| $L(n)$ | 16 | 44 | 100 | 212 | 436 |

$$r = \lceil \log_2 A \rceil$$

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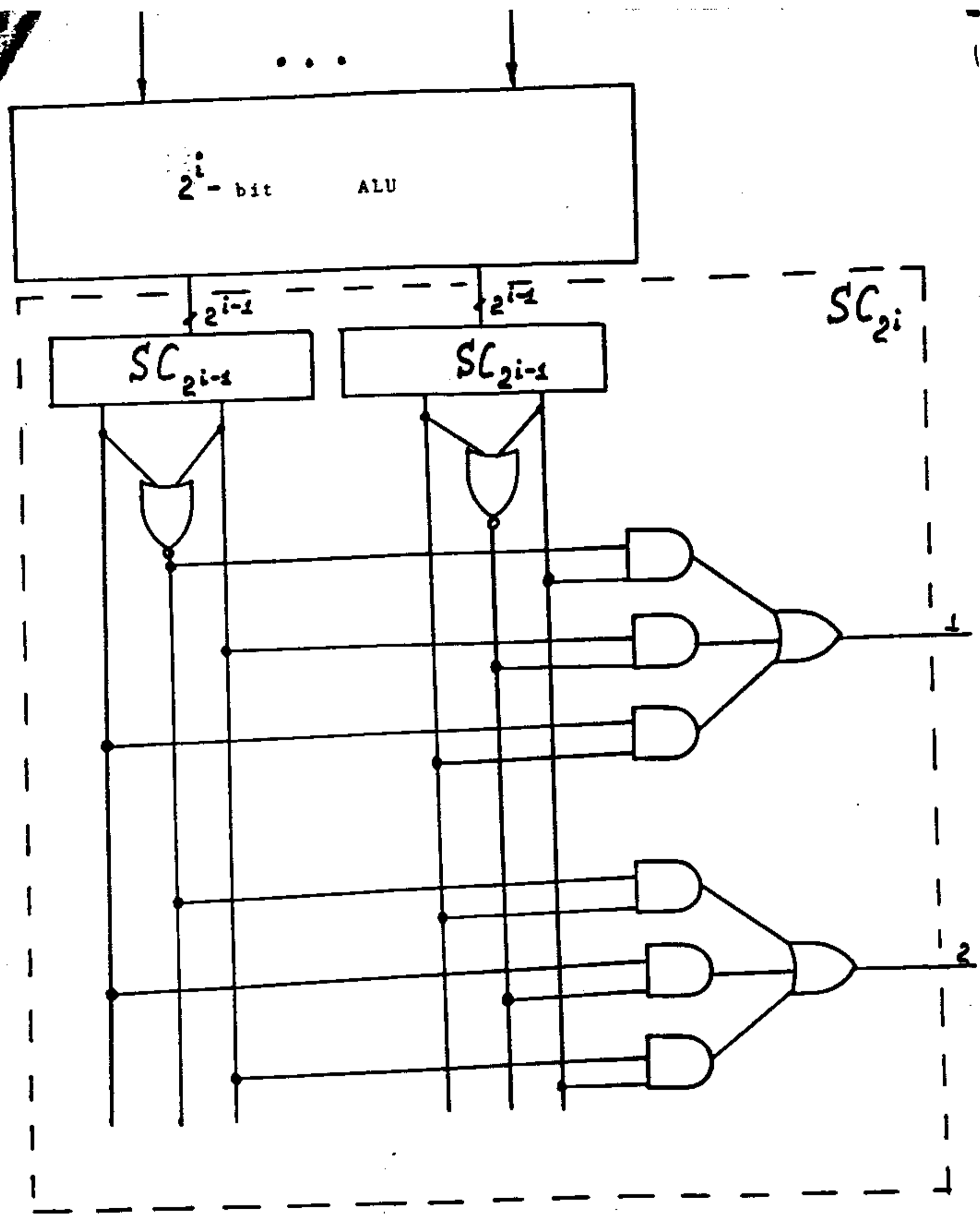
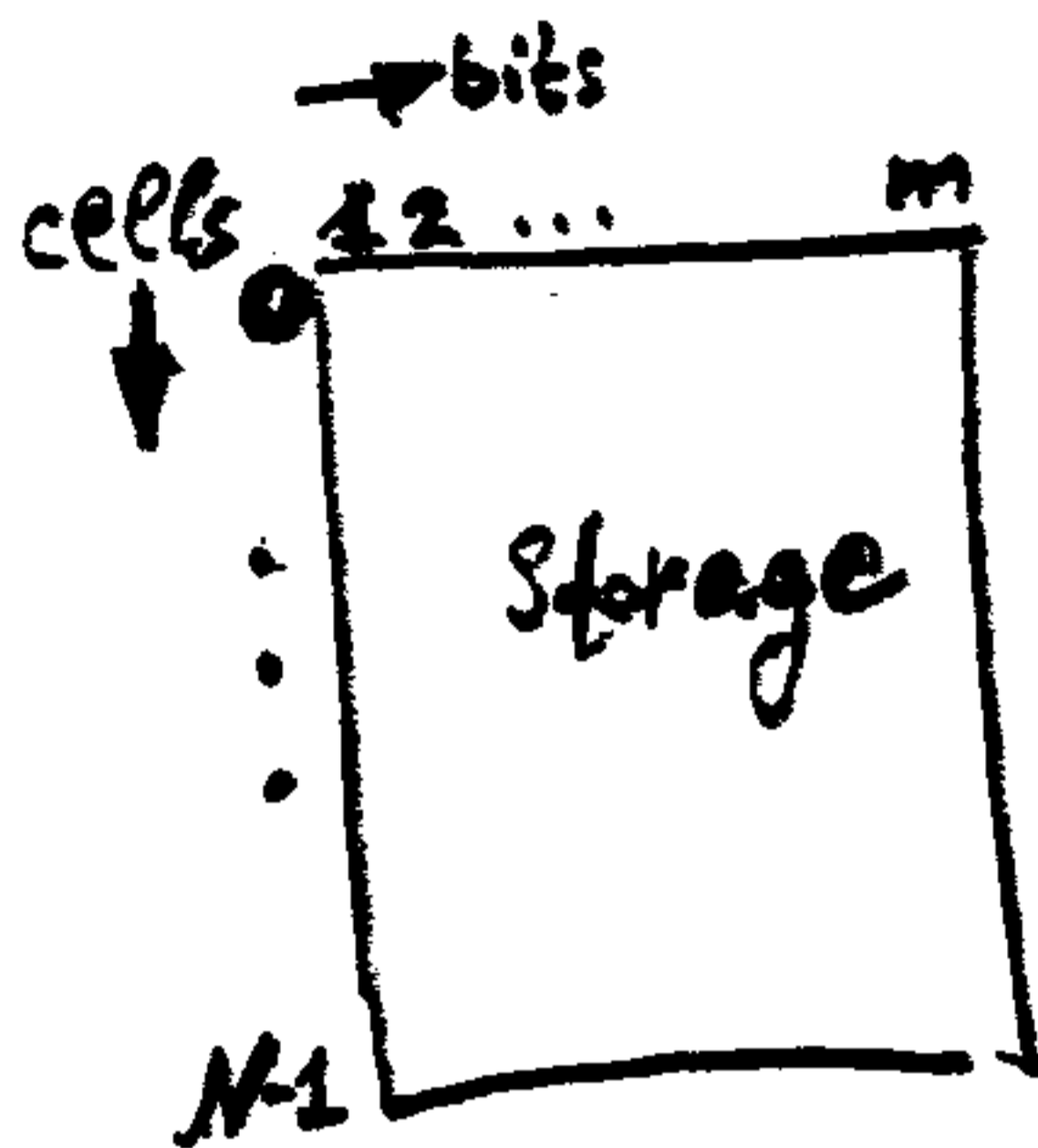


Fig. 6 Recursive procedure for the implementation of the SC with 2^i inputs by two SCs with 2^{i-1} inputs.

Check Sums for Memory Testing (ROM)



For every column:

$$\text{Checksum} = \sum_{i=0}^{N-1} W_i b_i$$

W_i - weights

b_i - binary value
of i th bit

If $W_i = 2^i \Rightarrow$ duplication

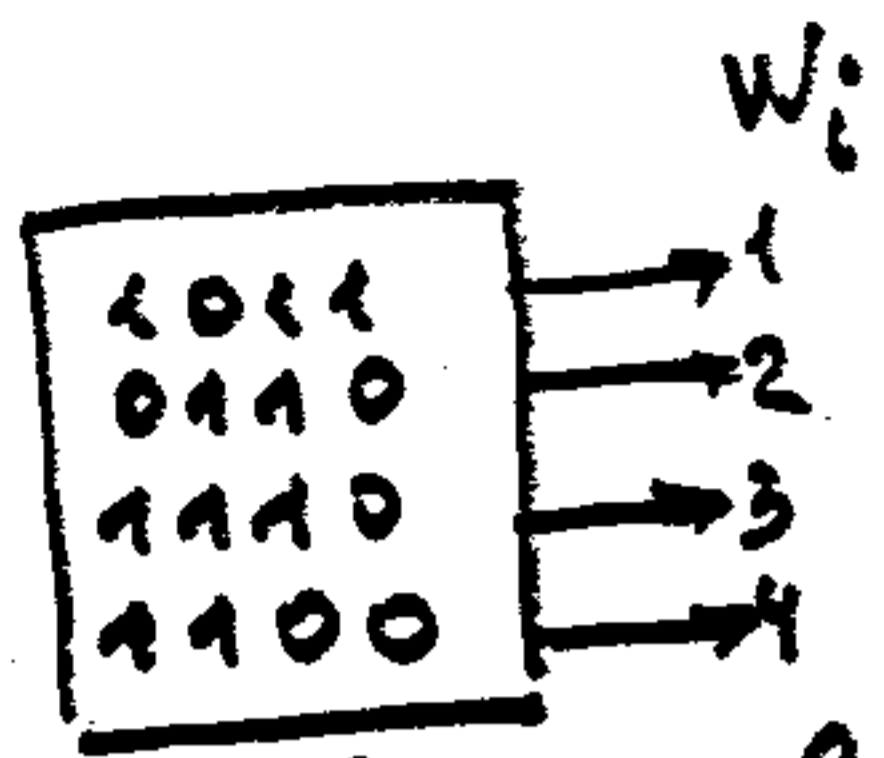
Take $W_i = i+1$.

Checksums are efficient for ROMs
and not very efficient for RAMs
(Not suitable for on-line testing)

Example 1.

$m=4, N=4.$

ROM



Checksum for the first column: $1+3+4=8$

For the second column: $2+3+4=9$

For the third column: $1+2+3=6$

For the fourth column: 1

Example 2

8K x 8 ROM \Rightarrow

26 bits for each checksum

Overhead: $26 \times 8 = 208$ bits

Space Overhead

$$\text{Check sum}_{\max} = \sum_{i=1}^N i = \frac{N(N+1)}{2}$$

$$\text{Space overhead} = m \lceil \log_2 \frac{N(N+1)}{2} \rceil = \approx 2m \log_2 N$$

For the previous example $N=8K, m=8$

$$\text{Space overhead} = 8 \cdot \lceil \log_2 \frac{8K \cdot 8K}{2} \rceil = 208$$

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 DETECTION OF SINGLE AND DOUBLE

 ERRORS

 CORRECTION OF SINGLE ERRORS

 IN ONE COLUMNS